PCN Number: 20190822002.1 PCN Date: Aug 23, 2019									019		
Title: Qualification of RFAB as an additional Wafer Fab Site option for select HPA07 devices in HPA07 Technology											
Customer Contact:		PCI	N Manager	Dept:			Qua	Quality Services			
Proposed 1 st Ship Date:		e: No	Nov 23, 2019		Estimated Sample Availability:		Date sam	Date provided at sample request.			
Change Ty	ype:										
Assembly Site			Assembly Pro		cess 🗌 /		Assemt	Assembly Materials			
Design			Electrical	Spee	cification 📃 M			Mechar	Mechanical Specification		
Test Site			Packing/Shipp		oing/Labeling			Test Process			
<u> </u>	Bump Site		Wafer Bump		1aterial			Wafer Bump Proc		SS	
🖄 Wafer	Fab Site		Wafer Fa	<u>b Ma</u>				Wafer F	Wafer Fab Process		
			_ Part number change								
PCN Details											
Description of Change:											
Texas Inst	ruments is ple	ased to a	announce t	ne qu	Jalification of			abricatio	n facility as	an	
auditional	waler Fab sou	rce for t	he selected	i uevi	ices listed in `	Produc	ι Al	rected	section.		
	Curren	t Sites				Additi	on	al Sites			
<u> </u>					Additional			al Sites	Wafer		
Eab Sit	re Proc	255	Diameter	er	Fab Site	Pro	HDA07		Diameter		
	5 HPA	07	200mm			н			300mm	-	
Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative): None											
Changes to product identification resulting from this PCN:											
Current		<u></u>	(201)	<u>.</u>	<u></u>	<u> </u>			<u></u>	1	
Chip Site	Chip	Chip Site Origin (20L)		Chip Site Country Code (21L)) Chip	Chip Site City			
DP1DM5	DM5	DM5		USA		Dalla	Dallas				
New Fab	Site										
Chip Site	Chip	Site Ori <mark>g</mark>	in (20L)	Chip	Site Country	Code (21L) Chip	Site City]	
RFAB	RFB			USA				Rich	ardson		
Sample product shipping label (not actual product label) TEXAS INSTRUMENTS MADE IN: Malaysia 20: MSL 2 /260C/1 YEAR SEAL DT OPT: ITEM: LBL: 5A (L)T0:1750 (not actual product label) (1P) SN74LS07NSR (Q) 2000 (D) 0336 (31T) LOT: 3959047MLA (4W) TKY (1T) 7523483S12 (P) COURSE: SHE (21L) CCO:USA (21L) CCO:USA (21L) CCO:USA											
Product Affected Group:											
TPS78001DDCR TPS		TPS7803	PS780330220DDCR		TPS78218DDCT			TPS78228DDCR			
TPS78001DDCRG4 TPS		TPS7803	330220DDC	Г	TPS78218DRVR			TPS78	TPS78228DDCT		
TPS78001DDCT TP		TPS7802	330220DRVF	ર	TPS78218DRVT			TPS78	TPS78228DRVR		
TPC72001			3302200101				TDC 70	TPS78228DRVRG4			
TPS/8001DRVR TPS		173/00.	JJUZZUDRV	IPS/0222DKVK			153/0	1F3/0220DKVKG4			

Texas Instruments Incorporated

PCN# 20190822002.1

TPS78001DRVRG4	TPS78101DDCR	TPS78222DRVT	TPS78228DRVT
TPS78001DRVT	TPS78101DDCT	TPS78223DDCR	TPS78230DDCR
TPS780180300DRVR	TPS78101DRVR	TPS78223DDCT	TPS78230DDCT
TPS780180300DRVT	TPS78101DRVT	TPS78225DDCR	TPS78230DRVR
TPS780230300DRVR	TPS781250200DDCR	TPS78225DDCT	TPS78230DRVT
TPS780230300DRVT	TPS781250200DDCT	TPS78225DRVR	TPS78233DDCR
TPS780270200DDCR	TPS781330220DDCR	TPS78225DRVT	TPS78233DDCT
TPS780270200DDCT	TPS781330220DDCRG4	TPS78227DDCR	TPS78236DDCR
TPS780300250DRVR	TPS781330220DDCT	TPS78227DDCT	TPS78236DDCT
TPS780300250DRVT	TPS781330220DRVR	TPS78227DRVR	TPS78236DRVR
TPS780330200DDCR	TPS781330220DRVT	TPS78227DRVT	TPS78236DRVT
TPS780330200DDCT	TPS78218DDCR		

Qualification Report

Approve Date 14-August-2019

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed **QBS** Process Qual Device: **Qual Device:** Туре **Test Name / Condition** Duration TPS78233DDCR Reference: TPS78218DRVR CD3232A1YFFR Per Datasheet ED **Electrical Characterization** Pass Pass -Parameters ELFR 3/3000/0 Early Life Failure Rate, 125C 48 Hours _ -HAST Biased HAST, 130C/85%RH 96 Hours 3/231/0 --HBM ESD - HBM 2000 V 1/3/0 3/9/0 -CDM ESD - CDM 500 V 1/3/0 3/9/0 -HTOL Life Test, 125C 1000 Hours 1/77/0 -HTOL Life Test, 140C 480 Hours --3/231/0 High Temp. Storage Bake, HTSL 420 Hours 3/231/0 --170C LU Latch-up (per JESD78) 1/6/0 3/18/0 -(per mfg. Site MQ Manufacturability (Assembly) Pass Pass Pass specification) (per mfg. Site Manufacturability (Wafer MQ Pass -Pass Fab) specification) Temperature Cycle, -TC 500 Cycles 3/231/0 _ _ 65/150C Unbiased HAST. UHAST 96 Hours 3/231/0 _ -130C/85%RH

- QBS: Qual By Similarity

- Qual Devices TPS78218DRVR and TPS78233DDCR are qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

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